TOSHIBA BI-DIRECTIONAL TRIODE THYRISTOR SILICON PLANAR TYPE

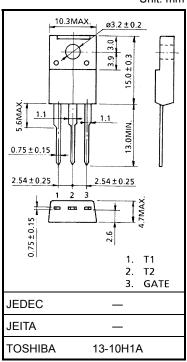
# SM8GZ47, SM8JZ47, SM8GZ47A, SM8JZ47A

## AC POWER CONTROL APPLICATIONS

- Repetitive Peak Off-State Voltage: VDRM = 400V, 600V
- R.M.S On-State Current: IT (RMS) = 8A
- High Commutating (dv / dt)
- Isolation Voltage: VISOL = 1500V AC

### **MAXIMUM RATINGS**

CHARACTERI	STIC	SYMBOL	RATING	UNIT	
Repetitive Peak	SM8GZ47 SM8GZ47A		400	V	
Off-State Voltage	SM8JZ47 SM8JZ47A	V <sub>DRM</sub>	600		
R.M.S On-State Curren (Full Sine Waveform Tc	•	I <sub>T (RMS)</sub>	8	А	
Peak One Cycle Surge	On-State	I <sub>TSM</sub>	80 (50Hz)	A	
Current (Non-Repetitive	e)		88 (60Hz)		
I <sup>2</sup> t Limit Value		l <sup>2</sup> t	32	A <sup>2</sup> s	
Critical Rate of Rise of C Current	On−State (Note 1)	di / dt	50	Α / μs	
Peak Gate Power Dissip	ation	P <sub>GM</sub>	5	W	
Average Gate Power Dis	ssipation	P <sub>G (AV)</sub>	0.5	W	
Peak Gate Voltage		V <sub>GM</sub>	10	V	
Peak Gate Current		I <sub>GM</sub>	2	А	
Junction Temperature		Tj	-40~125	°C	
Storage Temperature R	ange	T <sub>stg</sub>	-40~125	°C	
Isolation Voltage (AC, t	= 1min.)	VISOL	1500	V	



Weight: 1.7 g (typ.)

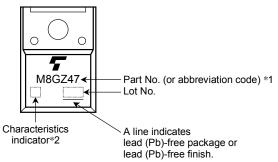
Note 1: di / dt Test Condition

 $V_{DRM} = 0.5 \times Rated$  $I_{TM} \le 12A$  $t_{gw} \ge 10 \mu s$  $t_{gr} \le 250 n s$  $i_{GP} = I_{GT} \times 2.0$  Unit: mm

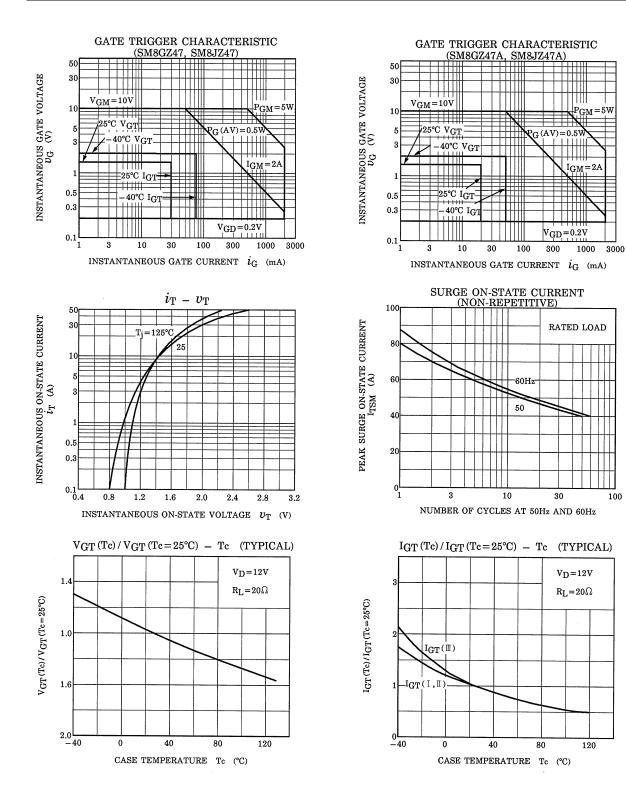
## ELECTRICAL CHARACTERISTICS (Ta = 25°C)

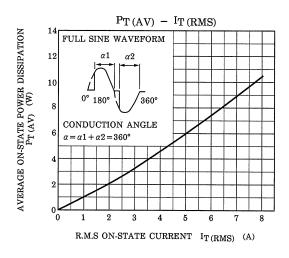
CHARACTERISTIC		SYMBOL	TEST CONDITION		MIN	TYP.	MAX	UNIT		
Repetitive Peak Off-State Current		I <sub>DRM</sub>	V <sub>DRM</sub> = Rated		_	_	20	μΑ		
I			Ι	V <sub>GT</sub> V <sub>D</sub> =	V <sub>D</sub> = 12V	T2 (+), Gate (+)	_	_	1.5	V
Gate Trigger Voltage		П	T2 (+), Gate (−)			_	_	1.5		
		III	$R_L^0 = 20\Omega$		T2 (−), Gate (−)	_	_	1.5		
		IV			T2 (-), Gate (+)	—	-	_		
			I	I <sub>GT</sub>	V <sub>D</sub> = 12V R <sub>L</sub> = 20Ω	T2 (+), Gate (+)	—	-	30	mA
	SM8GZ4		II			T2 (+), Gate (−)	—	—	30	
Gate Trigger Current	SM8JZ4	7	III			T2 (-), Gate (-)	_		30	
			IV			T2 (-), Gate (+)	_	_	-	
			I			T2 (+), Gate (+)	—	-	20	
	SM8GZ4		II			T2 (+), Gate (−)	—	—	20	
	SM8JZ4	7A	III			T2 (−), Gate (−)	_	-	20	
			IV			T2 (-), Gate (+)	_	_	_	
Peak On-State Voltage		V <sub>TM</sub>	I <sub>TM</sub> = 12A		_	—	1.5	V		
Gate Non-Trigger Voltage		V <sub>GD</sub>	V <sub>D</sub> = Rated, Tc = 125°C		0.2	_	_	V		
Holding Current		Ι <sub>Η</sub>	V <sub>D</sub> = 12V, I <sub>TM</sub> = 1A		_	_	50	mA		
Thermal Resistance		R <sub>th (j−c)</sub>	Junction to Case, AC		—	—	3.6	°C/W		
Critical Rate of SI Rise of Off-State Voltage SI		SM80 SM8J		dv / dt	V <sub>DRM</sub> = Rated, T <sub>j</sub> = 125°C Exponential Rise		_	300	_	V / µs
		SM80 SM8J	GZ47A Z47A				_	200	_	
Critical Rate of Rise of Off-State Voltage at Commutation			M8GZ47 M8JZ47 (dv / dt) c		V <sub>DRM</sub> = 400V, T <sub>j</sub> = 125°C		10	_	_	V / µs
		SM80 SM8J	6Z47A Z47A	(dv / dt) c $(di / dt) c = -4.5 A / m$		5Á / ms	4	_	_	v / µs

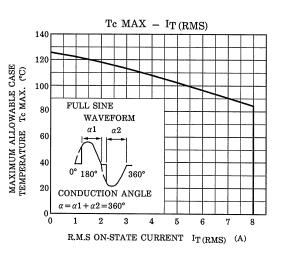
## MARKING



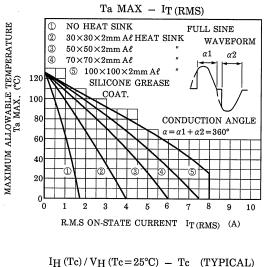
	Part No. (or abbreviation code)	Part No.
*1	M8GZ47	SM8GZ47, SM8GZ47A
	M8JZ47	SM8JZ47, SM8JZ47A
*2	Nothing	SM8GZ47, SM8JZ47
	А	SM8GZ47A, SM8JZ47A

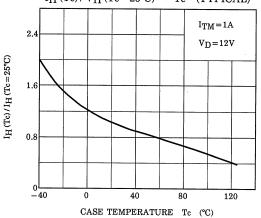


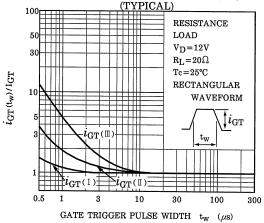


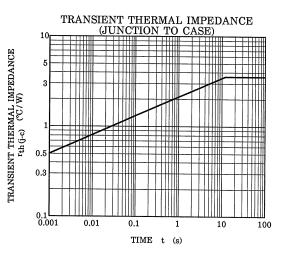


PULSE TRIGGER CHARACTERISTIC









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